

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
United States Patent and Trademark Office
Ableves, COMMERCHER OF PATENTS AND TRADEMARKS
Weshington, D.G. 20221
www.nepto.gov

| PPLICATION NO. | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. | |
|----------------------------|------------------|----------------------|---------------------|------------------|--|
| 09/966,740 | 10/01/2001 | Keiiti Ogura | 12732-077001/US5246 | 3604 | |
| 26171 7 | 590 03/18/2003 | | | | |
| FISH & RICHARDSON P.C. | | | EXAMINER | | |
| 1425 K STREE 11TH FLOOR | EI, N.W. | | DONG, DALEI | | |
| WASHINGTO | N, DC 20005-3500 | | | | |
| | | | ART UNIT | PAPER NUMBER | |

DATE MAILED: 03/18/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

| | | | | / | | | |
|--|--|---|---|-----------|--|--|--|
| | - | Application No. | Applicant(s) | XX | | | |
| | | 09/966,740 | OGURA ET AL. | | | | |
| Office Action Summ | .an. | Examiner | Art Unit | | | | |
| | | Dalei Dong | 2875 | | | | |
| The MAILING DATE of this c Period for Reply | ommunication appea | ars on the cover sheet with the c | orrespondence addre | ss | | | |
| A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. Extensions of time may be available unload the provisions of 37 CPR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing had been been as the six of t | | | | | | | |
| | on(s) filed on 06 Ma | roh 2002 | | | | | |
| Responsive to communication(s) filed on 06 March 2003. This action is FINAL. 2b) This action is non-final. | | | | | | | |
| 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213. | | | | | | | |
| Disposition of Claims | to practice under Ex | parte Quayle, 1935 C.D. 11, 45 | 53 O.G. 213. | | | | |
| 4) Claim(s) 1-55 is/are pending | | | | | | | |
| 4a) Of the above claim(s) 50-5 | | from consideration. | | | | | |
| 5) Claim(s) is/are allowed | i. | | • | | | | |
| Claim(s) <u>1-49</u> is/are rejected. | | | | | | | |
| 7) Claim(s) is/are objected | | | | | | | |
| 8) Claim(s) are subject to Application Papers | restriction and/or el- | ection requirement. | | | | | |
| 9)⊠ The specification is objected to | by the Examiner. | | | | | | |
| 10)⊠ The drawing(s) filed on <u>01 Octo</u> | ober 2001 is/are: a)[| □ accepted or b) □ objected to by | the Examiner. | | | | |
| Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). | | | | | | | |
| 11) The proposed drawing correction | on filed on is: | a) ☐ approved b) ☐ disapprov | ed by the Examiner. | | | | |
| If approved, corrected drawings | are required in reply to | o this Office action. | | | | | |
| Priority under 35 U.S.C. §§ 119 and 12 | 20 | | | | | | |
| 13) Acknowledgment is made of a | claim for foreign pri | ority under 35 U.S.C. § 119(a)- | (d) or (f). | | | | |
| a)⊠ All b)□ Some * c)□ Non | | , , , , , | (-) (-) | | | | |
| Certified copies of the presented copies. | riority documents ha | ive been received. | | | | | |
| Certified copies of the pr | riority documents ha | ve been received in Application | No. 09/966,740 . | | | | |
| Copies of the certified co application from the | opies of the priority of International Bureau | documents have been received (PCT Rule 17 2(a)) | in this National Stag | е | | | |
| * See the attached detailed Office | | | | | | | |
| 14) Acknowledgment is made of a cl | aim for domestic pri | ority under 35 U.S.C. § 119(e) | (to a provisional appl | ication). | | | |
| a) ☐ The translation of the foreign 15)☐ Acknowledgment is made of a c | gn language provisions | onal application has been receiving | ved. | | | | |
| Attachment(s) | for domestic pri | ioni, ander 55 0.5.0. 99 120 a | nuroi 121. | | | | |
| Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Rev Notice of Draftsperson's Patent Drawing Rev Notice of Draftsperson's Patent (s) (PTO-1- | view (PTO-948) 449) Paper No(s) | 4) Interview Summary (F 5) Notice of Informal Pat 6) Other: | PTO-413) Paper No(s) ent Application (PTO-152) | <u> </u> | | | |

DETAILED ACTION

Specification

- The disclosure is objected to because of the following informalities:
 - On page 3, line 9, "de3notes" should be "denotes".
 - On page 3, line 10, cathode designation numeral should be 1604 and not "1698". Appropriate correction is required.

Claim Rejections - 35 USC § 103

- The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior at are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- Claims 1-17 and 23-26 are rejected under 35 U.S.C. 103(a) as being unpatentable over
 U.S. Patent No. 5,990,615 to Sakaguchi in view of U.S. Patent No. 5 962 962 to Evitte

Regarding to claims 1-17 and 23-26, Sakaguchi discloses in Figure 1, an organic EL element comprising "a transparent anode layer 2 of indium tin oxide (ITO) is formed on a glass substrate 1 by using a sputtering method, and a hole injection-transport layer 3, a light emission layer 4, an electron transport layer 6 and a cathode 7 are subsequently formed on the anode layer 2 by using vacuum deposition method" (column 2, line 35-40).

Sakaguchi also discloses in Figure 1, "an insulative protective layer 8 for the organic EL element, oxide insulator such as SiO, MgO or Al₂O₃ is deposited on the

Application/Control Number: 09/966,740

Art Unit: 2875

cathode 7 by a vacuum deposition method with a thickness of 10 nm to 100 nm so as to cover all of upper surface of the cathode and side surfaces of its laminated body including from the hole-injection-transport layer 3 to the cathode 7" (column 2, line 41-47).

Sakaguchi further discloses in Figure 1, "as a method of sealing the thus prepared EL element body, a sealing member 9 having a cap structure is provided at the peripheral portion of the element, an an inert liquid 12 comprising a fluorocarbon such as perfluoroalkane or perfluoroamine with which a dehydrating agent 10 and/or an oxygen absorber 11 is/are mixed is filled therein. The sealing member can be made of metal or glass" (column 3, line 9-15).

However, Sakaguchi does not disclose the absorption film is a hygroscopic film. Fujita teaches, "a protective layer is formed on the periphery of a device having the above layer structure to cover the device, for preventing the infiltration of water into the device" (column 12. line 3-6).

Fujita also teaches "specific examples of the material for the protective layer include a copolymer obtained by conolymerizing a monomer mixture containing tetrafluoroethylene and at least one comonomer, a fluorine-containing copolymer of which the copolymer main chain contains a cyclic structure, polyethylene, polypropylene, polymethyl methacrylate, polyimide, polyurea, polytetrafluoroethylene, polychlorotrifluoroethylene, polydichlorodifluoroethylene, a copolymer from chlorotrifluoroethylene and dichlorodifluoroethylene, a water-absorption substance having a water absorption ratio of at least 1%, a humidity-preventive substance having a water absorption ratio of 0.1% or less, metals such as In, Sn, Pb, Au, Cu, Ag, Al, Ti and

Ni, metal oxides such as MgO, SiO, SiO.sub.2, Al.sub.2 O.sub.3, GeO, NiO, CaO, BaO, Fe.sub.2 O.sub.3, Y.sub.2 O.sub.3 and TiO.sub.2, and metal fluorides such as MgF.sub.2, LiF, AlF.sub.3 and CaF.sub.2" (column 13, line 63-67 to column 14, line 1-11).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize the protection layer of Fujita for the organic EL element of Sakaguchi in order to eliminate and prevent the moisture and undesired gas from infiltrating the light-emitting element and reduce the formation of black spot and thus prevent the oxidation by absorb the moisture within the device and furthermore prolong the lifetime of the device.

Claims 18-22 and 42-49 are rejected under 35 U.S.C. 103(a) as being unpatentable over
 U.S. Patent No. 5,684,365 to Tang in view of U.S. Patent No. 5,962,962 to Fujita.

Regarding to claims 18-22 and 42-49, Tang discloses in Figures 2 and 3, the construction of the electroluminescent device comprising an substrate of this device is an insulating and preferably transparent material such as quarteers level to the data line and the gate bus (row electrode) as the gate line. TFT2 is the EL power transistor in series with the EL element. The gate line of TFT2 is connected to the drain of TFT1. The storage capacitor is in series with TFT1. The anode of the EL element is connected to the drain of TFT2.

Tang also discloses "in another embodiment, the EL cathode is a bilayer composed of a lower layer of a low work function metal adjacent to the organic electron

injecting and transporting zone and, overlying the low work function metal, a protecting layer that protects the low work function metal from oxygen and humidity. Optionally, a passivation layer may be applied over the EL cathode layer" (column 10, line 8-14).

However, Tang does not disclose the absorption film is a hygroscopic film. Fujita teaches, "a protective layer is formed on the periphery of a device having the above layer structure to cover the device, for preventing the infiltration of water into the device" (column 12, line 3-6).

Fujita also teaches "specific examples of the material for the protective layer include a copolymer obtained by copolymerizing a monomer mixture containing tetrafluoroethylene and at least one comonomer, a fluorine-containing copolymer of which the copolymer main chain contains a cyclic structure, polyethylene, polypropylene, polymethyl methacrylate, polyimide, polyurea, polytetrafluoroethylene, polychlorotrifluoroethylene, polydichlorodifluoroethylene, a copolymer from chlorotrifluoroethylene and dichlorodifluoroethylene, a water-absorption substance having a water absorption ratio of at least 194. a hamiditu account water absorption ratio of 0.1% or less, metals such as In, Sn, Pb, Au, Cu, Ag, Al, Ti and Ni, metal oxides such as MgO, SiO, SiO.sub.2, Al.sub.2 O.sub.3, GeO, NiO, CaO, BaO, Fe.sub.2 O.sub.3, Y.sub.2 O.sub.3 and TiO.sub.2, and metal fluorides such as MgF.sub.2, LiF, AlF.sub.3 and CaF.sub.2" (column 13, line 63-67 to column 14, line 1-11).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize the protection layer of Fujita for the organic EL element of Tang in order to eliminate and prevent the moisture and undesired gas from

Application/Control Number: 09/966,740

Art Unit: 2875

infiltrating the light-emitting element and reduce the formation of black spot and thus prevent the oxidation by absorb the moisture within the device and furthermore prolong the lifetime of the device.

 Claims 27-41 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent No. 5,990,615 to Sakaguchi in view of U.S. Patent No. 5,962,962 to Fujita in further view of U.S. Patent No. 6,195,142 to Gyotoku.

Regarding to claims 27-33 and 36-41, Sakaguchi discloses a first substrate; an EL element comprising an organic light emitting layer formed over the first substrate; however, Sakaguchi fails to discloses a barrier film covering the EL element and an inorganic hygroscopic film formed over the barrier film.

Fujita teaches a inorganic hygroscopic film formed over the EL element, however fails to teach a barrier film covering the EL element. Gyotoku teaches in Figure 1, "the organic electroluminescence element is composed of a laminate structure formed of a substrate 1 an anode 2 dispensed on the sea purple of a substrate 1 an anode 2 dispensed on the sea purple of a substrate 1.

film layer 3 disposed on the <u>substrate</u> 1 and <u>anode</u> 2, a <u>cathode</u> 6 disposed on the top surface of the organic thin film layer 3, and a protective layer 7 (barrier film) disposed to cover the <u>cathode</u> 6 and organic thin film layer 3, and a shield material 8 disposed on the surface of the <u>substrate</u> to cover the outer surface of the laminate structure. In particular, the shield material 8 and <u>substrate</u> 1 are adhered through an adhesive layer 9" (column 5, line 61-67 to column 6, line 1-4).

Gyotoku also teaches, "as the protective layer 7, an insulating compound layer is used, for example, GeO, SiO, SiO.sub.2, MoO.sub.3, other oxide, AlN, Si.sub.3 N.sub.4, other nitride, PET, or other thermoplastic organic high polymer, and GeO is particularly preferred.

Gyotoku further teaches, "the reliability may be further enhanced by controlling the film thickness of the insulating compound layer as the protective layer 7, in particular, by laminating a metal conductive film on the protective layer 7" (column 8, line 39-42).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have disposed the barrier film of Gyotoku on the cathode of the organic EL element of Sakaguchi and utilize the protection layer of Fujita for the organic EL element of Sakaguchi in order to eliminate and prevent the moisture and undesired gas from infiltrating the light-emitting element and reduce the formation of black spot and thus prevent the oxidation by absorb the moisture within the device and furthermore prolong the lifetime of the device.

Regarding to claims 34 and 35, Sakaguchi discloses a protective insulating layer for the organic EL element. It would have been obvious to one of ordinary skill in the art at the time the invention was made to have dispose a layer of the protective insulating layer of Sakaguchi on the second substrate or easing of the organic EL element of Sakaguchi in order to prevent the moisture and undesired gas from infiltrating the lightemitting element and reduce the formation of black spot and thus prevent the oxidation

Application/Control Number: 09/966,740

Art Unit: 2875

by absorb the moisture within the device and furthermore prolong the lifetime of the device.

Conclusion

 The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

The following prior art are cited to further show the state of the art of composition of a organic EL element.

- U.S. Patent No. 5,909,081 to Eida.
- U.S. Patent No. 5,990,629 to Yamada.
- U.S. Patent No. 6,121,726 to Codama.
- U.S. Patent No. 6,160,346 to Vleggaar.
- U.S. Patent No. 6,172,459 to Hung.
- U.S. Patent No. 6,198,217 to Suzuki.
- II S Patent No. 6 525 220 to Motomaton

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dalei Dong whose telephone number is (703)308-2870. The examiner can normally be reached on 8 A.M. to 5 P.M..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Sandra O'Shea can be reached on (703)305-4939. The fax phone numbers for the

Art Unit: 2875

organization where this application or proceeding is assigned are (703)872-9318 for regular communications and (703)872-9319 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703)308-0956.

D.D.

March 11, 2003

Sandra O'Shea
Supervisory Patent Examiner
Technology Center 2800